

MOSFET - N-Channel, DUAL COOL®, POWERTRENCH®

120 V, 128 A, 4.2 m Ω

FDMT800120DC

General Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process. Advancements in both silicon and DUAL COOL package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

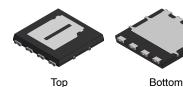
Features

- Max $r_{DS(on)} = 4.2 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 20 \text{ A}$
- Max $r_{DS(on)} = 6.4 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 16 \text{ A}$
- Advanced Package and Silicon Combination for Low r_{DS(on)} and High Efficiency
- Next Generation Enhanced Body Diode Technology, Engineered for Soft Recovery
- Low Profile 8x8 mm MLP Package
- MSL1 Robust Package Design
- 100% UIL Tested
- This Device is RoHS Compliant

Typical Applications

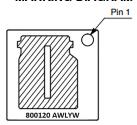
- OringFET/Load Switching
- Synchronous Rectification
- DC-DC Conversion

V _{DS}	R _{DS(on)} MAX	I _D MAX
120 V	4.2 mΩ @ 10 V	128 A
	6.4 mΩ @ 6 V	



TDFNW8 8.3 x 8.4, 2P, DUAL COOL, OPTION 2 CASE 507AR

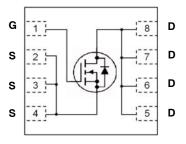
MARKING DIAGRAM



800120 = Device Code A = Assembly Location

WL = Wafer Lot
 Y = Year
 W = Work Week

ELECTRICAL CONNECTION



N-Channel MOSFET

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 7 of this data sheet.

MOSFET MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter				Rating	Unit
V_{DS}	Drain to Source Voltage			120	V	
V _{GS}	Gate to Source V	/oltage			±20	V
I _D	Drain Current	-Continuous	T _C = 25°C	(Note 5)	128	Α
		-Continuous	T _C = 100°C	(Note 5)	81	
		-Continuous	T _A = 25°C	(Note 1a)	20	
		-Pulsed		(Note 4)	767	
E _{AS}	Single Pulse Ava	lanche Energy		(Note 3)	1350	mJ
P_{D}	Power Dissipatio	n	T _C = 25°C		156	W
	Power Dissipatio	n	T _A = 25°C	(Note 1a)	3.2	
T _J , T _{STG}	Operating and St	torage Junction Temper	ature Range		-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter		Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	1.6	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	0.8	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	15	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	21	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	9	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CHAP	RACTERISTICS			•	•	
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	120	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	97	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 96 V, V _{GS} = 0 V	-	-	1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	-	100	nA
ON CHAR	ACTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	3.1	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	-12	-	mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 20 A	_	3.45	4.2	mΩ
		V _{GS} = 6 V, I _D = 16 A	_	4.6	6.4	
		V _{GS} = 10 V, I _D = 20 A, T _J = 125°C	_	6.3	7.7	
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 20 A	_	69	_	S
DYNAMIC	CHARACTERISTICS					
C _{iss}	Input Capacitance	V _{DS} = 60 V, V _{GS} = 0 V, f = 1 MHz	_	5605	7850	pF
C _{oss}	Output Capacitance	1	_	778	1090	pF
C _{rss}	Reverse Transfer Capacitance	1	_	27	40	pF
R _g	Gate Resistance		0.1	1.4	3.5	Ω
SWITCHIN	IG CHARACTERISTICS					
td _(on)	Turn-On Delay Time	V _{DD} = 60 V, I _D = 20 A,	_	29	47	ns
t _r	Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	_	18	33	
t _{d(off)}	Turn-Off Delay Time	1	_	40	64	
t _f	Fall Time	1	_	9.5	19	
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V, V _{DD} = 60 V, I _D = 20 A	-	76	107	nC
		V _{GS} = 0 V to 6 V, V _{DD} = 60 V, I _D = 20 A	-	48	68	
Q _{gs}	Gate to Source Charge	V _{DD} = 60 V, I _D = 20 A	-	25	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	<u>]</u>	-	15	-	nC
DRAIN-SC	DURCE DIODE CHARACTERISTICS					
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.9 \text{ A}$ (Note 2)	-	0.7	1.1	V
		V _{GS} = 0 V, I _S = 20 A (Note 2)	-	0.8	1.2	1
t _{rr}	Reverse Recovery Time	I _F = 20 A, di/dt = 100 A/μs	-	87	139	ns
Q _{rr}	Reverse Recovery Charge]	_	164	263	nC

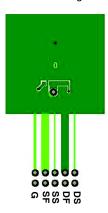
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

THERMAL CHARACTERISTICS

Symbol	Parameter		Ratings	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Top Source)	1.6	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	0.8	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	14	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	60	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	15	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	21	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	9	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	11	

NOTES:

 R_{0,JA} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{0CA} is determined by the user's board design.



 a) 38°C/W when mounted on a 1 in² pad of 2 oz copper.



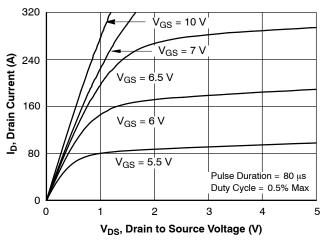
b) 81°C/W when mounted on a minimum pad of 2 oz copper.

- c) Still air, $20.9 \times 10.4 \times 12.7$ mm Aluminum Heat Sink, 1 in² pad of 2 oz copper
- d) Still air, $20.9 \times 10.4 \times 12.7$ mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e) Still air, 45.2 × 41.4 × 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- f) Still air, 45.2 × 41.4 × 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g) 200 FPM Airflow, No Heat Sink, 1 in² pad of 2 oz copper
- h) 200 FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i) 200 FPM Airflow, $20.9 \times 10.4 \times 12.7$ mm Aluminum Heat Sink, 1 in² pad of 2 oz copper
- j) 200 FPM Airflow, $20.9 \times 10.4 \times 12.7$ mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k) 200 FPM Airflow, $45.2 \times 41.4 \times 11.7$ mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in 2 pad of 2 oz copper the companion of the comp
- I) 200 FPM Airflow, 45.2 × 41.4 × 11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width $< 300 \mu s$, Duty cycle < 2.0%.
- 3. E_{AS} of 1350 mJ is based on starting $T_J = 25^{\circ}C$; N-ch: L = 3 mH, $I_{AS} = 30$ A, $V_{DD} = 120$ V, $V_{GS} = 10$ V. 100% test at L = 0.1 mH, $I_{AS} = 93$ A.
- 4. Pulsed Id please refer to Figure 11 SOA graph for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

 $V_{GS} = 5.5 \text{ V}$

4



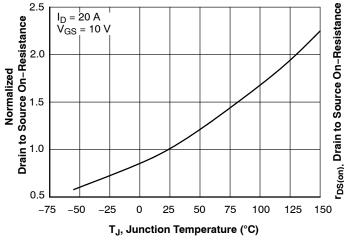
Normalized Drain to Source On-Resistance V_{GS} = 6.5 V 3 2 V_{GS} = 10 V Pulse Duration = 80 μs $V_{GS} = 7 V$ Duty Cycle = 0.5% Max 0 0 80 160 240 320

 $V_{GS} = 6 V$

Figure 1. On Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

I_D, Drain Current (A)



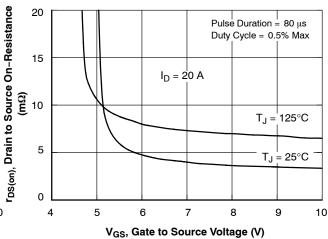
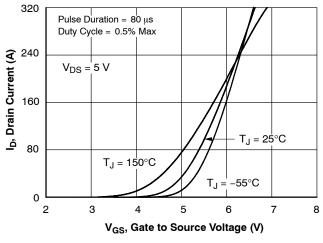


Figure 3. Normalized On Resistance vs. Junction Temperature

Figure 4. On-Resistance vs. Gate to Source Voltage



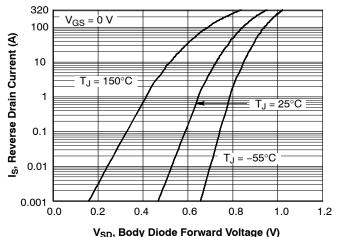
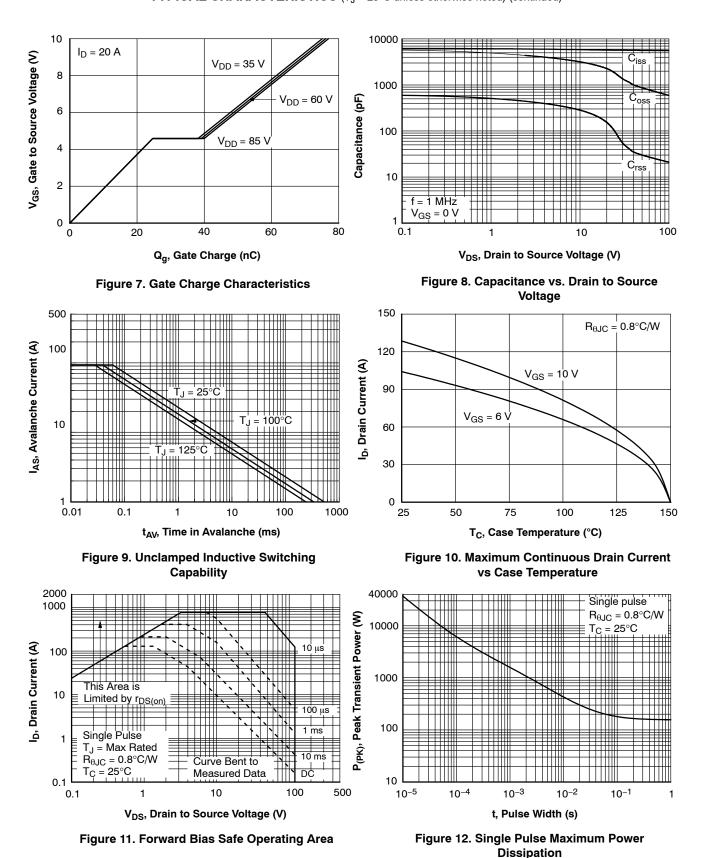


Figure 5. Transfer Characteristics

Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)



TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

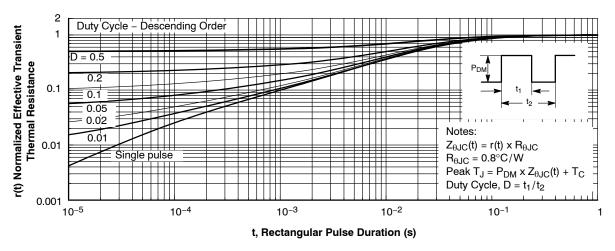


Figure 13. Junction-to-Case Transient Thermal Response Curve

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Shipping [†]
800120	FDMT800120DC	TDFNW8 8.3 \times 8.4, 2P, DUAL COOL, OPTION 2	13"	13.3 mm	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

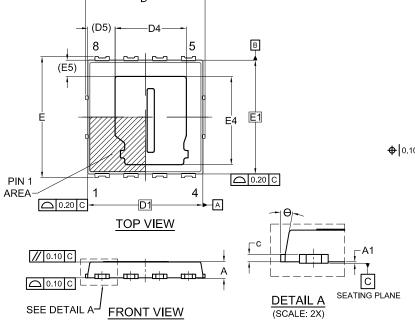


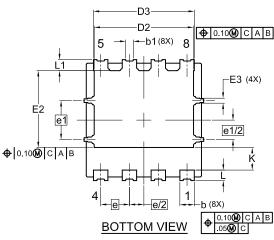


TDFNW8 8.30x8.40x0.92, 2.00P

CASE 507AR **ISSUE C**

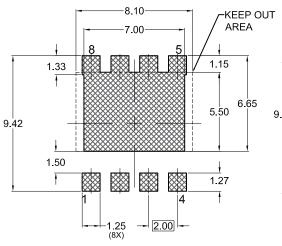
DATE 29 MAY 2024

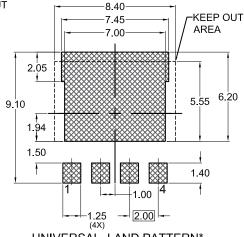




NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M, 2009. 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS. OR GATE BURRS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.





RECOMMENDED LAND PATTERN

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

UNIVERSAL	LAND PATTERN*

DIM	MILLIMETERS			
DIM	MIN.	NOM.	MAX.	
Α	0.82	0.92	1.02	
A1	0.00	_	0.05	
b	0.90	1.00	1.10	
b1	0.35	0.45	0.55	
С	0.23	0.28	0.33	
D	8.20	8.30	8.40	
D1		8.00 BSC		
D2	6.80	6.90	7.00	
D3	6.90	7.00	7.10	
D4	4.90	5.05	5.20	
D5	1.85 REF			
E	8.30	8.40	8.50	
E1		7.90 BSC	;	
E2	5.24	5.34	5.44	
E3	0.25	0.35	0.45	
E4	6.08	6.23	6.38	
E5		1.13 RE	F	
е		2.00 BS	С	
e/2		1.00 BS	С	
e1		2.70 BS	С	
e1/2	1.35 BSC			
K	1.50	1.57	1.70	
L	0.64	0.74	0.84	
L1	0.67	0.77	0.87	
θ	0°		12°	

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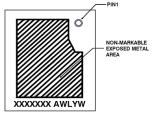
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CASE 507AR ISSUE C

DATE 29 MAY 2024

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
W = Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

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